

Application/Control No.	Applicant(s)/Patent under Reexamination  LEES ET AL.	
10/616,187		
Examiner	Art Unit	
Jo Ann Rinaudo	1644	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
TE	EXMR			
2005	JR			
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